

Fixed capacitors for use in electronic equipment –

Part 1: Generic specification

CORRIGENDUM 1

4.5.6 Conditions to be prescribed the relevant specification

Replace in item b) 4.5.3 by 4.5.4.

4.11.2 Inductance

Replace the formula $L_X = \frac{1}{4^2 \times f_r^2 \times C_X}$

by the formula $L_X = \frac{1}{4\pi^2 \times f_r^2 \times C_X}$

4.25.1.2 Test procedure

Add, after the first paragraph, the following sentence:

The test specimens may be introduced into the chamber at any temperature from laboratory temperature to the upper category temperature.